



## AOP600

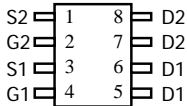
### Complementary Enhancement Mode Field Effect Transistor

#### General Description

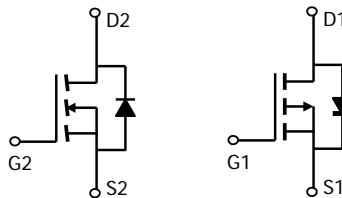
The AOP600 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. The complementary MOSFETs form a high-speed power inverter, suitable for a multitude of applications. *Standard Product AOP600 is Pb-free (meets ROHS & Sony 259 specifications). AOP600L is a Green Product ordering option. AOP600 and AOP600L are electrically identical.*

#### Features

| n-channel                       | p-channel                           |
|---------------------------------|-------------------------------------|
| $V_{DS}$ (V) = 30V              | -30V                                |
| $I_D = 7.5A$ ( $V_{GS} = 10V$ ) | -6.6A                               |
| $R_{DS(ON)}$<br>< 28m $\Omega$  | < 35m $\Omega$ ( $V_{GS} = -10V$ )  |
| < 43m $\Omega$                  | < 58m $\Omega$ ( $V_{GS} = -4.5V$ ) |



PDIP-8



n-channel

p-channel

#### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                              | Symbol                 | Max n-channel          | Max p-channel | Units            |
|--|------------------------|------------------------|---------------|------------------|
| Drain-Source Voltage                   | $V_{DS}$               | 30                     | -30           | V                |
| Gate-Source Voltage                    | $V_{GS}$               | $\pm 20$               | $\pm 20$      | V                |
| Continuous Drain Current <sup>A</sup>  | $T_A=25^\circ\text{C}$ | 7.5                    | -6.6          | A                |
|  |                        | $T_A=70^\circ\text{C}$ | 6             |                  |
| Pulsed Drain Current <sup>B</sup>      | $I_{DM}$               | 30                     | -30           |                  |
| Power Dissipation                      | $T_A=25^\circ\text{C}$ | 2.5                    | 2.5           | W                |
|  |                        | $T_A=70^\circ\text{C}$ | 1.6           |                  |
| Junction and Storage Temperature Range | $T_J, T_{STG}$         | -55 to 150             | -55 to 150    | $^\circ\text{C}$ |

#### Thermal Characteristics: n-channel

| Parameter                                | Symbol          | Typ          | Max | Units              |
|--|-----------------|--------------|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | 40           | 50  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A</sup> |                 | Steady-State | 67  | 80                 |
| Maximum Junction-to-Lead <sup>C</sup>    | $R_{\theta JL}$ | 33           | 40  | $^\circ\text{C/W}$ |

#### Thermal Characteristics: p-channel

| Parameter                                | Symbol          | Typ          | Max | Units              |
|--|-----------------|--------------|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | 38           | 50  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A</sup> |                 | Steady-State | 66  | 80                 |
| Maximum Junction-to-Lead <sup>C</sup>    | $R_{\theta JL}$ | 30           | 40  | $^\circ\text{C/W}$ |

n-channel MOSFET Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol                      | Parameter                             | Conditions  | Min | Typ   | Max    | Units |
|-----------------------------|---------------------------------------|---|-----|-------|--------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |   |     |       |        |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V  | 30  |       |        | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =24V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                         |     |       | 1<br>5 | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V  |     |       | 100    | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                  | 1   | 1.8   | 3      | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V   | 30  |       |        | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =7.5A<br>T <sub>J</sub> =125°C                       |     | 22.6  | 28     | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =6.0A   |     | 33    | 43     | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =7.5A   | 12  | 16    |        | S     |
| V <sub>SD</sub>             | Body Diode Forward Voltage            | I <sub>S</sub> =1A, V <sub>GS</sub> =0V   |     | 0.76  | 1      | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |   |     |       | 4      | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |     |       |        |       |
| C <sub>iss</sub>            | Input Capacitance                     |   |     | 680   | 820    | pF    |
| C <sub>oss</sub>            | Output Capacitance.                   | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz   |     | 102   |        | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |   |     | 77    |        | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz  |     | 3     | 3.6    | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |   |     |       |        |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                     |   |     | 13.84 | 16.6   | nC    |
| Q <sub>g</sub>              | Total Gate Charge                     | V <sub>GS</sub> =4.5V, V <sub>DS</sub> =15V, I <sub>D</sub> =7.5A                         |     | 6.74  | 8.1    | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |   |     | 1.82  |        | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |   |     | 3.2   |        | nC    |
| t <sub>D(on)</sub>          | Turn-On Delay Time                    |   |     | 4.6   |        | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =2.0Ω,<br>R <sub>GEN</sub> =6Ω |     | 4.1   |        | ns    |
| t <sub>D(off)</sub>         | Turn-Off Delay Time                   |   |     | 20.6  |        | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |   |     | 5.2   |        | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery time      | I <sub>F</sub> =7.5A, dI/dt=100A/μs   |     | 16.5  | 20     | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery charge    | I <sub>F</sub> =7.5A, dI/dt=100A/μs   |     | 7.8   |        | nC    |

A: The value of R<sub>θJA</sub> is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using 80 μs pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: N-CHANNEL

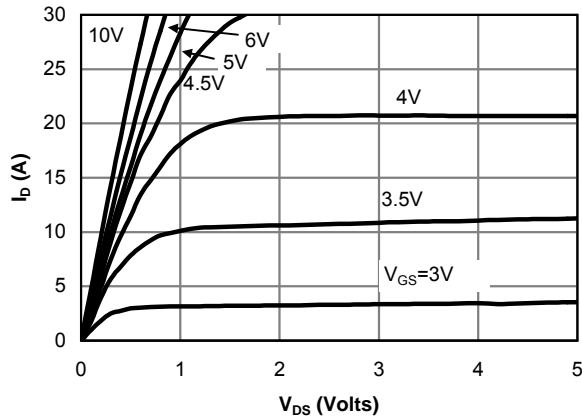


Fig 1: On-Region Characteristics

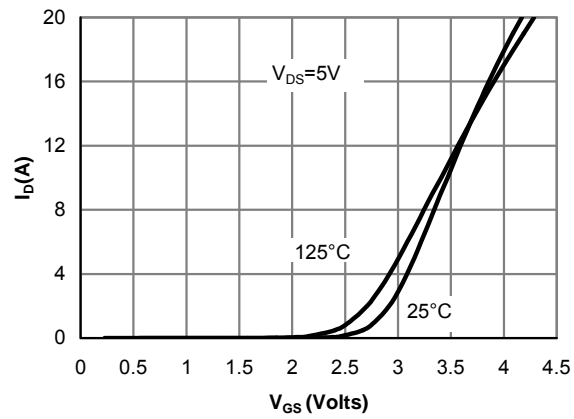


Figure 2: Transfer Characteristics

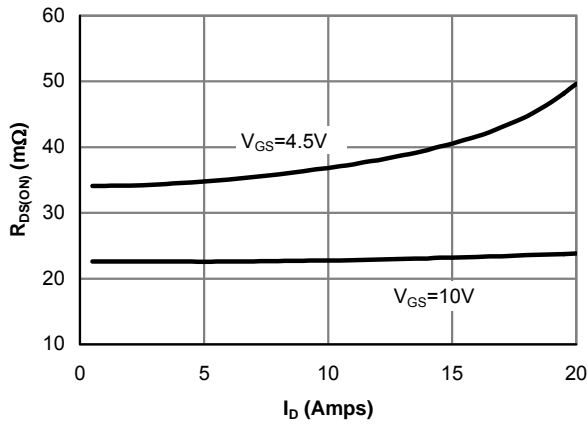


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

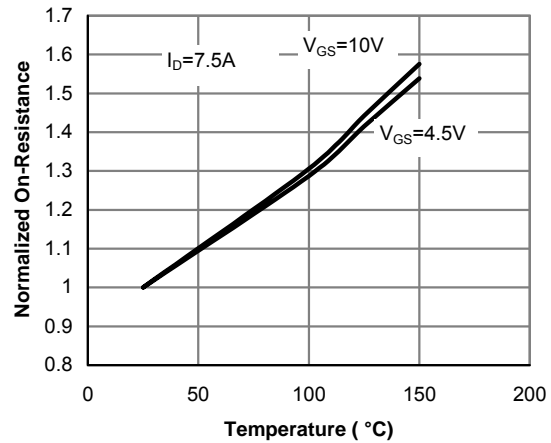


Figure 4: On-Resistance vs. Junction Temperature

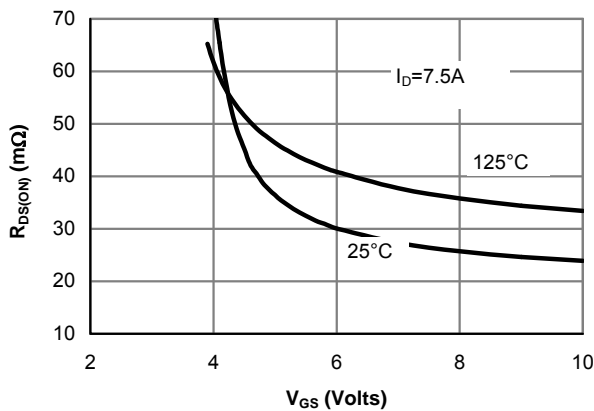


Figure 5: On-Resistance vs. Gate-Source Voltage

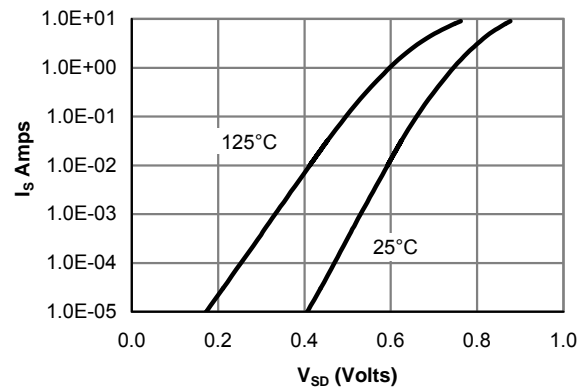


Figure 6: Body diode characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: N-CHANNEL

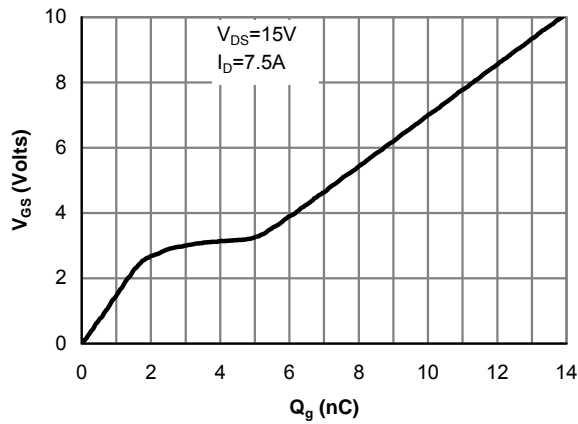


Figure 7: Gate-Charge characteristics

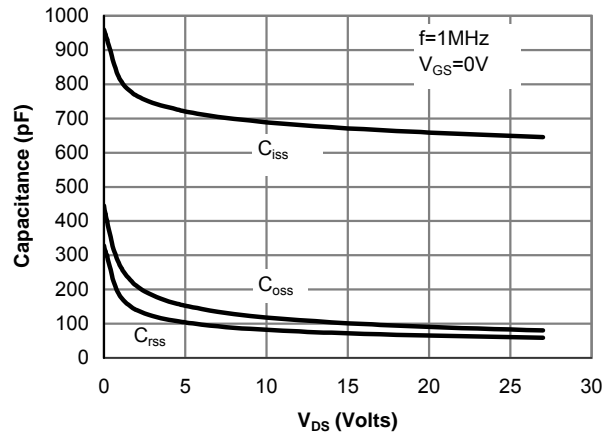


Figure 8: Capacitance Characteristics

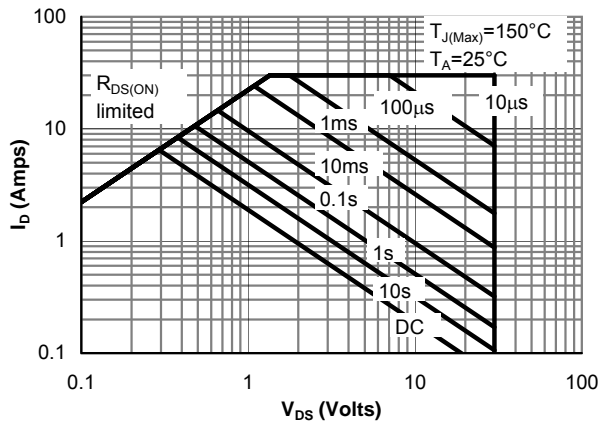


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

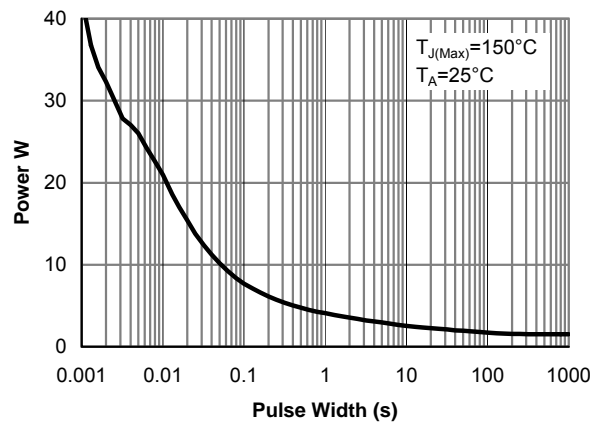


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

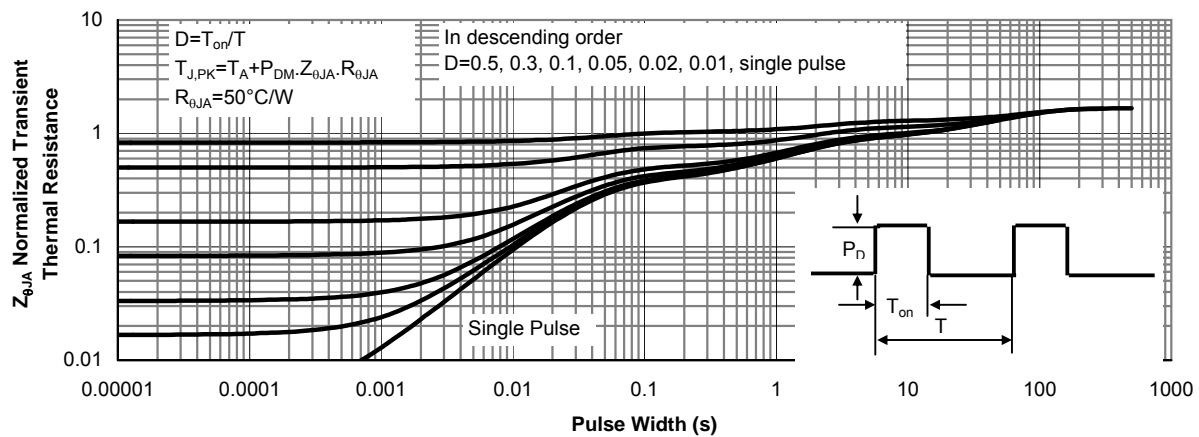


Figure 11: Normalized Maximum Transient Thermal Impedance

p-channel MOSFET Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol                      | Parameter                             | Conditions  | Min  | Typ      | Max      | Units |
|-----------------------------|---------------------------------------|---|------|----------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |   |      |          |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V   | -30  |          |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =-24V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                          |      |          | -1<br>-5 | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V  |      |          | ±100     | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA                                   | -1.2 | -2       | -2.4     | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-5V   | 30   |          |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =-10V, I <sub>D</sub> =-6.6A<br>T <sub>J</sub> =125°C                       |      | 28<br>37 | 35<br>45 | mΩ    |
|                             |                                       | V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-5A   |      | 44       | 58       | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =-5V, I <sub>D</sub> =-6.6A   |      | 13       |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =-1A, V <sub>GS</sub> =0V  |      | -0.76    | -1       | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |   |      |          | -4.2     | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |      |          |          |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, f=1MHz  |      | 920      | 1100     | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |   |      | 190      |          | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |   |      | 122      |          | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz  |      | 3.6      | 4.4      | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |   |      |          |          |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge (10V)               | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-6.6A                         |      | 18.5     | 22.2     | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge (4.5V)              |   |      | 9.6      | 11.6     | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |   |      | 2.7      |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |   |      | 4.5      |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, R <sub>L</sub> =2.3Ω,<br>R <sub>GEN</sub> =3Ω |      | 7.7      |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |   |      | 5.7      |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |   |      | 20.2     |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |   |      | 9.5      |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =-6.6A, dI/dt=100A/μs  |      | 20       | 24       | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =-6.6A, dI/dt=100A/μs  |      | 8.8      |          | nC    |

A: The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80 μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

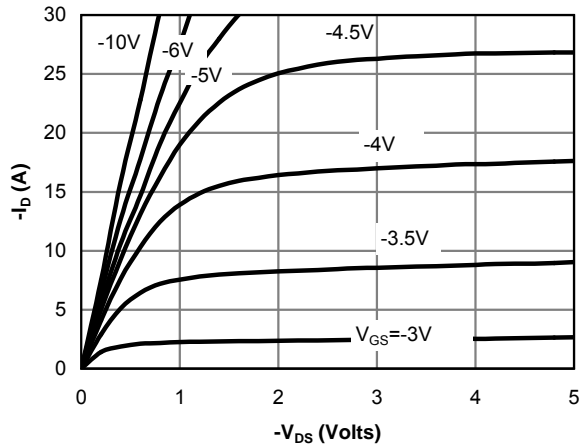


Fig 1: On-Region Characteristics

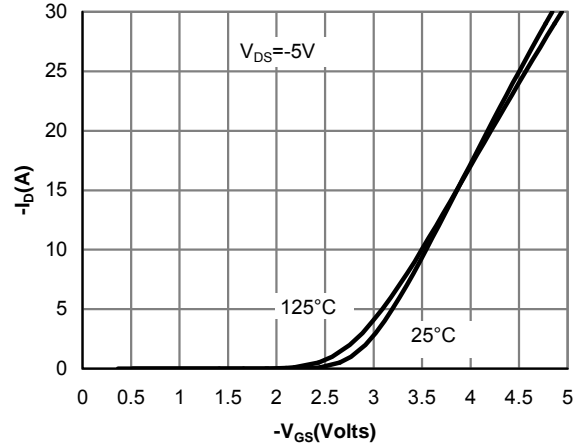


Figure 2: Transfer Characteristics

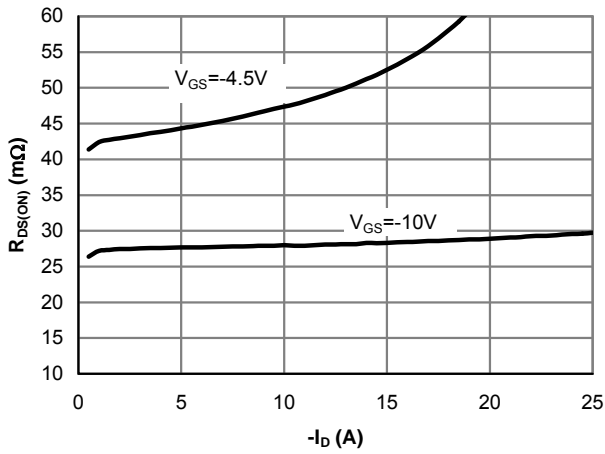


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

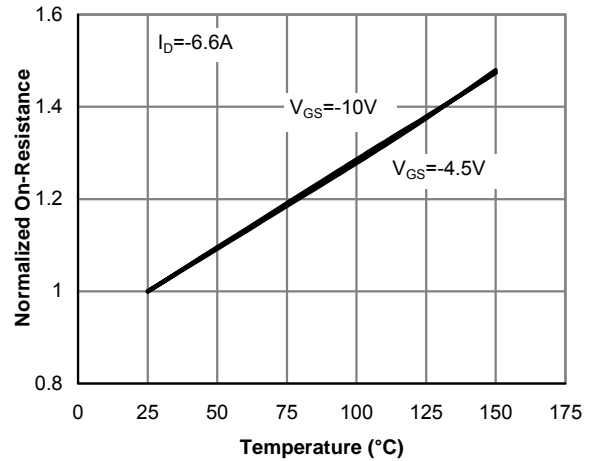


Figure 4: On-Resistance vs. Junction Temperature

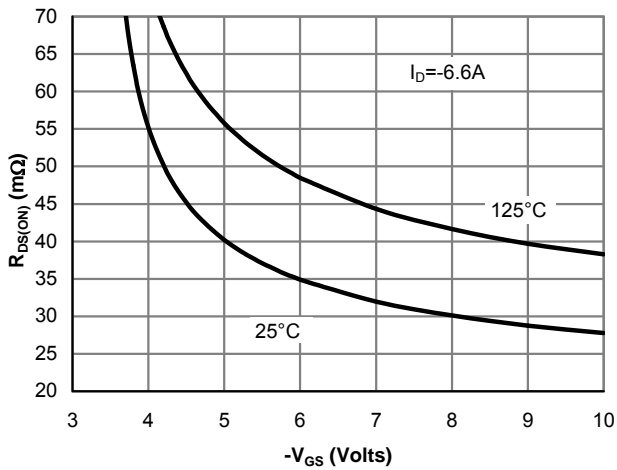


Figure 5: On-Resistance vs. Gate-Source Voltage

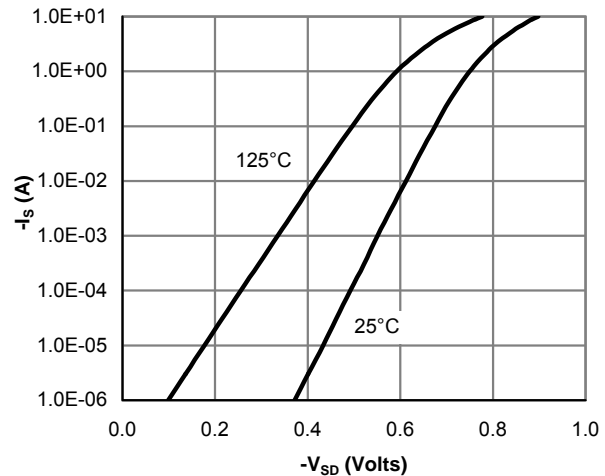


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

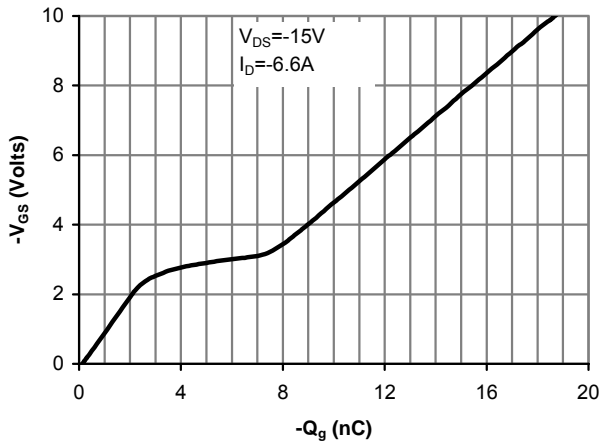


Figure 7: Gate-Charge Characteristics

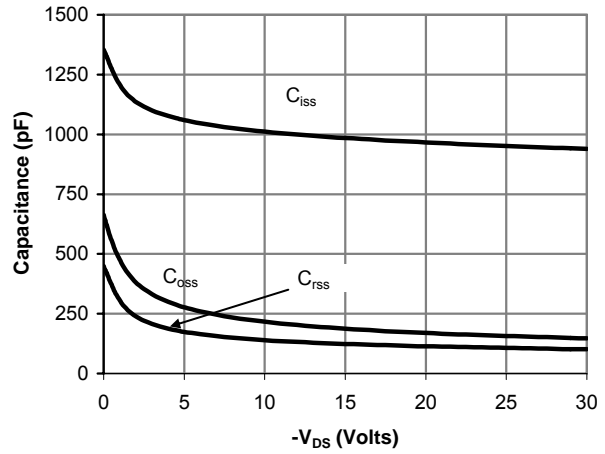


Figure 8: Capacitance Characteristics

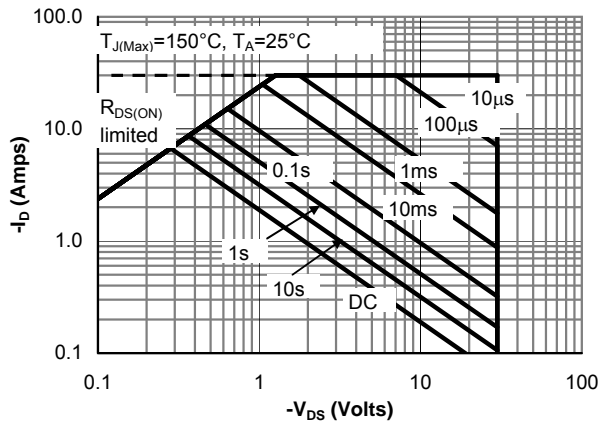


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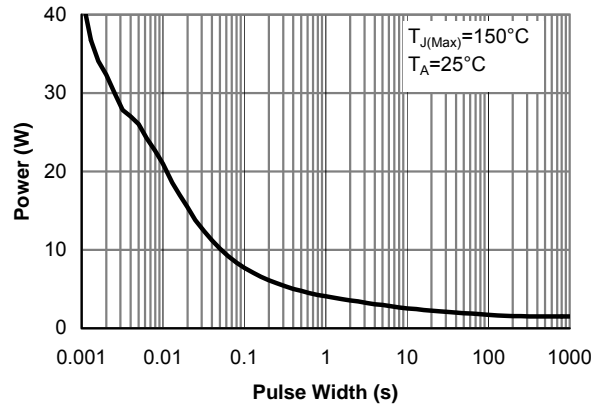


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

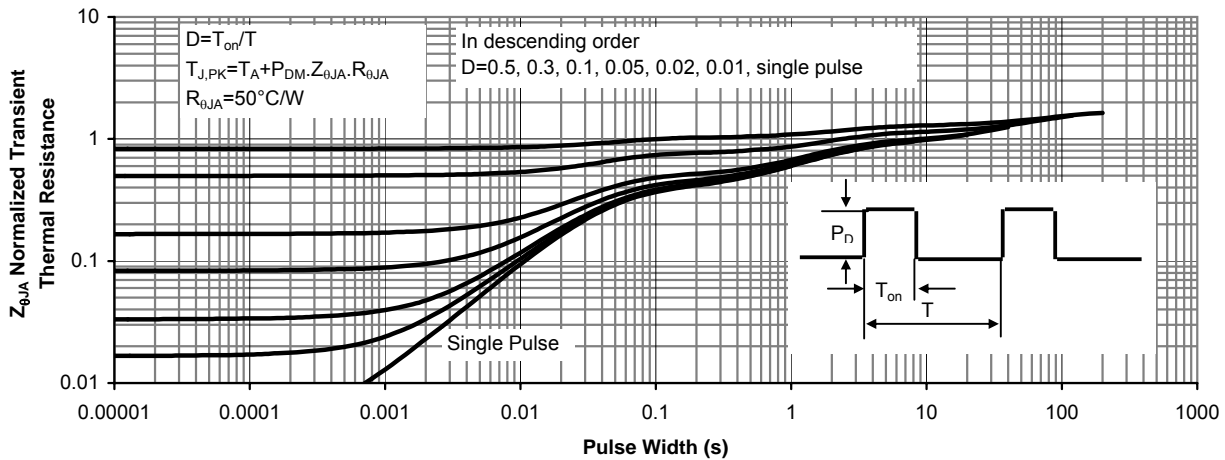


Figure 11: Normalized Maximum Transient Thermal Impedance